

Notice of References Cited	Application/Control No. 10/775,145	Applicant(s)/Patent Under Reexamination HAYAMI ET AL.	
	Examiner Maureen Gramaglia	Art Unit 1716	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,817,377	11-2004	Reimer et al.	137/565.23
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	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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